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Application/Control N	o. Applicant(s)/Patent u Reexamination	nder
10/526,921	MARRA ET AL.	
Examiner	Art Unit	
Evan Dzierzynski	2875	

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	SEAR	CHED	
Class	Subclass	Date	Examiner
362	337	7/5/2006	ED
	335	7/5/2006	ED
	327	7/5/2006	ED

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Search advice from Jim Cranson	7/5/2006	ED	
EAST word search, attached	7/5/2006	ED	
EAST word search, updated & attached	11/29/2006	ED	
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